

## Amendments to the Harmonized System Explanatory Notes – HS Committee 62<sup>nd</sup> Session

The following list contains the decisions taken by the Harmonized System Committee (62<sup>nd</sup> Session – September 2018) concerning amendments to the Harmonized System Explanatory Notes, applicable as of 1 December 2018. This publication will be updated regularly.

The Harmonized System Explanatory Notes are published by WCO in 5 volumes (2017 edition) and reflect the official interpretation of the Harmonized Commodity Description and Coding System. They also contain the text of the Subheading Explanatory Notes indicating the scope and content of certain of the Harmonized System Subheadings. The Explanatory Notes are available in English and French, the two official languages of the WCO, and can be ordered directly (see “Bookshop” on this Web site). They are also available on-line.

The amendments listed below are reproduced in the order of the current pages concerned and will be incorporated into the aforementioned WCO publications in due time by replacing the pages affected by the amendments made.

### **Advice**

Parties seeking to import or export merchandise covered by a decision are advised to verify the implementation of the decision by the importing or exporting country, as the case may be.

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AMENDMENTS TO THE EXPLANATORY NOTES

CHAPTER 29.

Page VI-29-List I-13.

II. Psychotropic substances subject to control under the 1971 Convention on Psychotropic Substances.

d-9-Tetrahydrocannabinol.

Delete “2932.99” in the “**HS subheading**” column and substitute “2932.95.”.

(Doc. NC2570E1b/M/20)

CHAPTER 90.

Heading 90.27. Page XVIII-9027-6. New Item (33).

Insert the following new Item (33):

“(33) **Instruments and apparatus used in clinical laboratories for *in vitro* diagnostic testing.**”.

(Doc. NC2570E1b/M/15)

Heading 90.31. Page XVIII-9031-6.

Subheading 9031.41. Subheading Explanatory Note.

Delete and substitute:

“**Subheading 9031.41.**

This subheading also covers optical instruments and appliances for inspecting integrated circuits and optical instruments and appliances for inspecting photomasks or reticles used in manufacturing integrated circuits.”.

(Doc. NC2570E1b/M/1)

